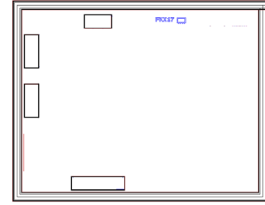


Ultra High Dynamic Range Monolithic Amplifier Die

PHA-202-D+

50Ω 0.3 to 2.7 GHz



The Big Deal

- Ultra High IP3, +46.1 dBm
- Broadband High Dynamic Range without external Matching Components
- Medium power, 1W
- Excellent return loss over 15 dB

Product Overview

PHA-202-D+ (RoHS compliant) is a medium power amplifier die fabricated using E-PHEMT technology and offers extremely high dynamic range over a broad frequency range and with low noise figure. In addition, the PHA-202-D+ has good input and output return loss over a broad frequency range without the need for external matching components and has demonstrated excellent reliability.

Key Features

| Feature | Advantages |
|--|---|
| Broad Band: 0.03 to 2.7 GHz | Broadband covering primary wireless communications bands: Cellular, PCS, LTE |
| Extremely High IP3 Versus DC power Consumption 46 dBm typical at 1.0 GHz | The PHA-202-D+ matches industry leading IP3 performance relative to device size and power consumption. The combination of the design and E-PHEMT Structure provides enhanced linearity over a broad frequency range as evidence in the IP3 being typically 14-23 dB above the P1dB point. This feature makes this amplifier ideal for use in: <ul style="list-style-type: none">• Driver amplifiers for complex waveform up converter paths• Drivers in linearized transmit systems• Secondary amplifiers in ultra High Dynamic range receivers |
| No External Matching Components Required | Unlike competing products, Mini-Circuits PHA-202-D+ provides Input and Output Return Loss of over 15 dB up to 2 GHz without the need for any external matching components |



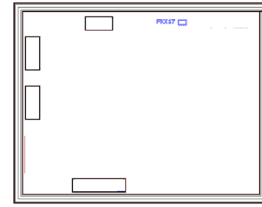
Ultra High Dynamic Range Monolithic Amplifier Die

PHA-202-D+

50Ω 0.3 to 2.7 GHz

Product Features

- High IP3, 46.1 dBm typ. at 1 GHz
- Gain, 17.0 dB typ. at 1 GHz
- High Pout, P1dB 30.4 dBm typ. at 1 GHz
- No external matching components required



Typical Applications

- Base station infrastructure
- CATV & DBS
- LTE

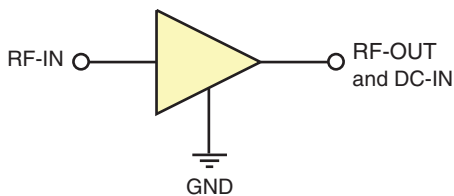
+RoHS Compliant
The +Suffix identifies RoHS Compliance. See our web site for RoHS Compliance methodologies and qualifications

Ordering Information: Refer to Last Page

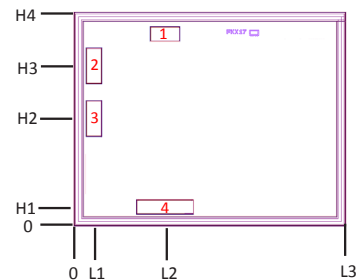
General Description

PHA-202-D+ (RoHS compliant) is a medium power amplifier die fabricated using E-PHEMT technology and offers extremely high dynamic range over a broad frequency range and with low noise figure. In addition, the PHA-202-D+ has good input and output return loss over a broad frequency range without the need for external matching components and has demonstrated excellent reliability.

Simplified Schematic and Pad description



Bonding Pad Position



Dimensions in μm , Typical

| Pad# | Function | Description |
|------|----------------|--|
| 1 | RF-IN | RF input pad. This pad requires the use of an external DC blocking capacitor chosen for the frequency of operation |
| 4 | RF-OUT & DC-IN | RF output pad and bias pad. DC voltage is present on this pad, therefore, a DC blocking capacitor is necessary for proper operation. An RF choke is needed to feed DC bias without loss of RF signal due to the bias connection. |
| 2,3 | GND | Connections to ground. Bottom of die. |

Note: 1. Bond Pad material - Gold
2. Bottom of Die - Gold plated

| L1 | L2 | L3 | H1 | H2 | H3 | H4 | Thickness | Width | Length | RF-IN Bond Pad Size | RF-OUT + DC-IN Bond Pad Size | Ground Bond Pad Size |
|------|-----|------|----|-------|-------|------|-----------|-------|--------|---------------------|------------------------------|----------------------|
| 77.5 | 436 | 1325 | 73 | 517.5 | 782.5 | 1030 | 100 | 1325 | 1030 | 140 x 70 | 280 x 65 | 70 x 170 |



Electrical Specifications at 25°C, 50 ohms, unless noted

| Parameter | Condition (MHz) | Vd=11V ¹ | | | Units |
|---|-----------------|---------------------|--------|------|-------|
| | | Min. | Typ. | Max. | |
| Frequency range | | 0.03 | | 2.7 | GHz |
| Gain | 30 | | 18.3 | | dB |
| | 500 | | 17.9 | | |
| | 1000 | | 17.0 | | |
| | 2000 | | 14.7 | | |
| | 2700 | | 12.7 | | |
| Input return loss | 30 | | 21.2 | | dB |
| | 500 | | 21.7 | | |
| | 1000 | | 19.5 | | |
| | 2000 | | 20.3 | | |
| | 2700 | | 14.9 | | |
| Output return loss | 30 | | 15.1 | | dB |
| | 500 | | 16.4 | | |
| | 1000 | | 19.4 | | |
| | 2000 | | 22.5 | | |
| | 2700 | | 9.8 | | |
| Reverse isolation | 2000 | | 23 | | dB |
| Output power @ 1dB compression | 30 | | 28.4 | | dBm |
| | 500 | | 30.2 | | |
| | 1000 | | 30.4 | | |
| | 2000 | | 28.1 | | |
| | 2700 | | 25.7 | | |
| Output IP3 ² | 30 | | 51.0 | | dBm |
| | 500 | | 48.5 | | |
| | 1000 | | 46.1 | | |
| | 2000 | | 43.2 | | |
| | 2700 | | 39.4 | | |
| Noise figure | 30 | | 3.2 | | dB |
| | 500 | | 3.3 | | |
| | 1000 | | 3.5 | | |
| | 2000 | | 4.4 | | |
| | 2700 | | 5.4 | | |
| Device operating voltage | | | 11 | | V |
| Device operating current | | — | 350 | 416 | mA |
| Device current variation vs voltage ³ | | | 0.0485 | | mA/mV |
| Thermal Resistance, junction-to-ground lead at 85°C stage temp. | | | 16.1 | | °C/W |

1. Measured on Mini-Circuits Characterization test board. Die package in 5x6mm, 8-lead MCLP package and soldered on test board MB018

2. Tested at Pout=16dBm / tone.

3. (Current at 11.5V-current - Current at 10.5V)/1000

Absolute Maximum Ratings⁴

| Parameter | Ratings |
|-------------------------------------|--|
| Operating Temperature (ground lead) | -40°C to 85°C |
| Junction Temperature | 179°C |
| Power Dissipation | 5.8W |
| Input Power (CW) ¹ | +24 dBm (5 minutes max.) +19 dBm (continuous) |
| DC Voltage on Pad#4 ¹ | 14V |

4 Permanent damage may occur if any of these limits are exceeded. Electrical maximum ratings are not intended for continuous normal operation.

Characterization Test Circuit

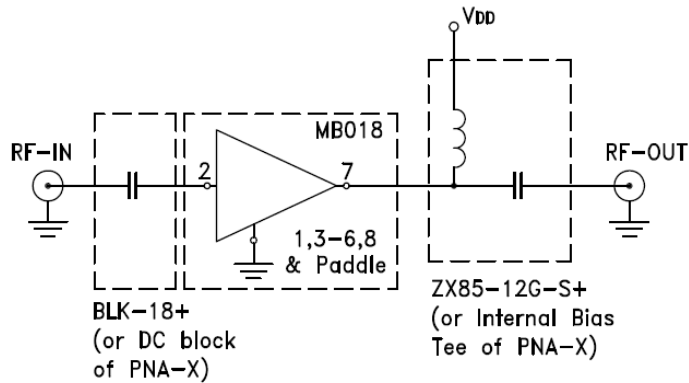


Fig 1. Characterization Circuit

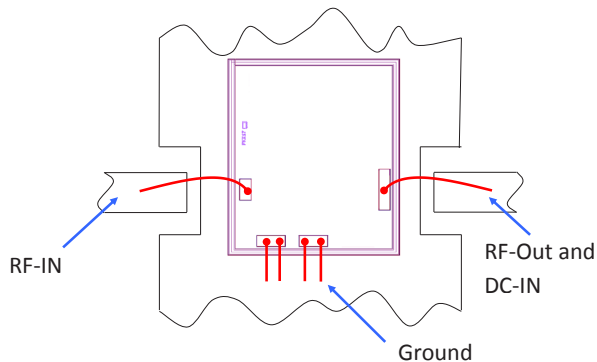
Note: This block diagram is used for characterization. (Die packaged in 5x6mm, 8-lead MCLP package and soldered on Mini-Circuits Characterization test board MB018)

Gain, Return loss, Output power at 1dB compression (P1 dB), output IP3 (OIP3) and noise figure measured using Agilent's N5242A PNA-X microwave network analyzer.

Conditions:

1. Gain and Return loss: Pin= -25dBm
2. Output IP3 (OIP3): Two tones, spaced 1 MHz apart, 16 dBm/tone at output.

Assembly Diagram



Assembly and Handling Procedure

1. Storage
Dice should be stored in a dry nitrogen purged desiccators or equivalent.
2. ESD
MMIC E-PHEMT amplifier dice are susceptible to electrostatic and mechanical damage. Die are supplied in antistatic protected material, which should be opened in clean room conditions at an appropriately grounded anti-static workstation. Devices need careful handling using correctly designed collets, vacuum pickup tips or sharp antistatic tweezers to deter ESD damage to dice.
3. Die Attach
The Die mounting surface must be clean and flat. Using conductive silver filled epoxy, recommended epoxies are DieMat DM6030HK-PT/H579 or Ablestik 84-1LMISR4. Apply sufficient epoxy to meet required epoxy bond line thickness, epoxy fillet height and epoxy coverage around total Die periphery. Parts shall be cured in a nitrogen filled atmosphere per manufacturer's cure condition. It is recommended to use antistatic Die pick up tools only.
4. Wire Bonding
Bond pad openings in the surface passivation above the bond pads are provided to allow wire bonding to the dice gold bond pads. Thermosonic bonding is used with minimized ultrasonic content. Bond force, time, ultrasonic power and temperature are all critical parameters. Suggested wire is pure gold, 1 mil diameter. Bonds must be made from the bond pads on the Die to the package or substrate. All bond wires should be kept as short as low as reasonable to minimize performance degradation due to undesirable series inductance.

| Additional Detailed Technical Information <i>additional information is available on our dash board.</i> | |
|---|---|
| Performance Data | Data Table |
| | Swept Graphs |
| | S-Parameter (S2P Files) Data Set with and without port extension(.zip file) |
| Case Style | Die |
| Die Ordering and packaging information | Quantity, Package Model No. |
| | Small, Gel - Pak: 5,10,50,100 KGD* PHA-202-DG+ Medium†, Partial wafer: KGD* <5K PHA-202-DP+ Large†, Full Wafer PHA-202-DF+ |
| | † Available upon request contact sales representative |
| | Refer to AN-60-067 |
| Environmental Ratings | ENV08T1 |

*Known Good Dice ("KGD") means that the dice in question have been subjected to Mini-Circuits DC test performance criteria and measurement instructions and that the parametric data of such dice fall within a predefined range. While DC testing is not definitive, it does help to provide a higher degree of confidence that dice are capable of meeting typical RF electrical parameters specified by Mini-Circuits.

ESD Rating**

Human Body Model (HBM): Class 1B (pass 500V) in accordance with ANSI/ESD STM 5.1 - 2001

** Tested in industry standard 5x6mm, 8-lead MCLP package

Additional Notes

- A. Performance and quality attributes and conditions not expressly stated in this specification document are intended to be excluded and do not form a part of this specification document.
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